

Notice of References Cited	Application/Control No. 10/629,629		Applicant(s)/Patent Under Reexamination DE MARTIN, GIOVANNI	
	Examiner Erika Garrett		Art Unit 3636	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,033,020 A	03-2000	Ito, Tsunetaro	297/302.4
	B	US-6,139,103 A	10-2000	Hybarger et al.	297/300.5
	C	US-6,120,096 A	09-2000	Miotto, Beniamino	297/301.4
	D	US-5,294,178 A	03-1994	Bogle et al.	297/302.4
	E	US-5,280,998 A	01-1994	Miotto et al.	297/302.4
	F	US-6,523,897 B2	02-2003	Pan, Toung Chun	297/302.1
	G	US-6,131,998 A	10-2000	Su, Tung-Hua	297/374
	H	US-6,139,103 A	10-2000	Hybarger et al.	297/300.5
	I	US-6,213,552 B1	04-2001	Miotto, Beniamino	297/300.5
	J	US-6,116,688 A	09-2000	Wilkerson et al.	297/316
	K	US-6,276,755 B1	08-2001	Su, Tung-Hua	297/285
	L	US-4,025,020	05-1977	Goff et al.	248/582
	M	US-5,762,399	06-1998	Liu, Clement	297/302.7

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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